

FORM PTO-1449	ATTY. DKT NO.	01-166	SER. NO.	
	APPLICANT	KIKKAWA et al.		
	FILING DATE	July 3, 2001	GROUP	

11036 U.S. PTO
09/897015
07/03/01

REFERENCE DESIGNATION

U.S. PATENT DOCUMENTS

EXAMINER INITIAL	DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS
fm	5,224,096	June 29, 1993	Onishi et al.		

FOREIGN PATENT DOCUMENTS

								TRANSLATION	
		DOCUMENT NUMBER	DATE	COUNTRY	NAME	CLASS	SUB CLASS	YES	NO
<i>fm</i>		EP 0886404 A2 (Discussed on page 2 of the spec.)	23/12/98	EUROPE				X	
<i>fm</i>		JP-A-8-204879	8/9/96	JAPAN				X	
<i>fm</i>		JP-A-2000-183940	6/30/00	JAPAN				X	

OTHER REFERENCES (including Author, Title, Date, Pertinent Pages, etc.)

EXAMINER	<i>Anthony J. ...</i>	DATE CONSIDERED <i>2/25/05</i>

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PATENT APPLICATION

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	APPLICANT	KIKKAWA et al.		
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REFERENCE DESIGNATION

U.S. PATENT DOCUMENTS

EXAMINER INITIAL	DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS

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FOREIGN PATENT DOCUMENTS

								TRANSLATION	
		DOCUMENT NUMBER	DATE	COUNTRY	NAME	CLASS	SUB CLASS	YES	NO
gmk		JP-A-H08-335948	12/17/96	JAPAN				X (Abstract)	

* Full English text of the JP Document will be available in machine-translated form from JP (Japanese Patent Office)
English language web site at <http://www1.ipdl.jpo.go.jp/PA1/cgi-bin/PA1INDEX>.

OTHER REFERENCES (including Author, Title, Date, Pertinent Pages, etc.)

EXAMINER	<i>Anthony J. Miller</i>	DATE CONSIDERED	<i>2/25/05</i>
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